1058785 0

Application/Control No.	Applicant(s)/Patent Under Reexamination
10587850	MAYER ET AL.
Examiner	Art Unit
DEREK S CHAPEL	2872

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the lack of unity	8/25/2008	DSC
Consulted with Lee Fineman about the rejections under 112	6/17/2009	DSC
Reviewed art cited in international case	6/11/2009	DSC
EAST Class/Subclass Search: 359/483, 485-488, 490-493, 495-497, 500, 502, 629-640; 349/96; 385/11; 353/20; 362/19 (text only, see attached)	7/1/2010	DSC
EAST Update Search, see attached	11/7/2010	DSC
EAST Update Search, see attached	12/16/2010	DSC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see .clm. search	11/8/2010	DSC
	see .clm. search	12/16/2010	DSC

/D. S. C./ Examiner.Art Unit 2872	

U.S. Patent and Trademark Office Part of Paper No.: 12162010